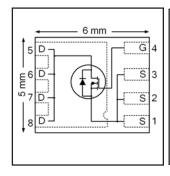




## HEXFET® Power MOSFET

V <sub>DS</sub>	150	V
<b>R</b> <sub>DS(on) max</sub> (@V <sub>GS</sub> = 10V)	31	$\mathbf{m}\Omega$
Q <sub>g</sub> (typical)	36	nC
R <sub>G (typical)</sub>	1.7	Ω
I <sub>D</sub>	44	Α
$(@T_{mb} = 25^{\circ}C)$		, ,





### **Applications**

- Primary Side Synchronous Rectification
- Inverters for DC Motors
- DC-DC Brick Applications
- Boost Converters

### Features and Benefits

### **Features**

Low RDSon (< 31 m $\Omega$ )	
Low Thermal Resistance to PCB (<0.8°C/W)	
100% Rg tested	
Low Profile (<0.9 mm)	results in
Industry-Standard Pinout	$\Rightarrow$
Compatible with Existing Surface Mount Techniques	
RoHS Compliant Containing no Lead, no Bromide and no Halogen	
MSL1, Industrial Qualification	
	_

### **Benefits**

	Lower Conduction Losses
	Increased Power Density
	Increased Reliability
า	Increased Power Density
	Multi-Vendor Compatibility
	Easier Manufacturing
	Environmentally Friendlier
	Increased Reliability

Base Part Number	Package Type	Standar	d Pack	Orderable Part Number
		Form	Quantity	
IRFH5015PBF	PQFN 5mm x 6mm	Tape and Reel	4000	IRFH5015TRPBF

## **Absolute Maximum Ratings**

	Parameter	Max.	Units
$V_{DS}$	Drain-to-Source Voltage	150	V
$V_{GS}$	Gate-to-Source Voltage	±20	V
I <sub>D</sub> @ T <sub>A</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	10	
Continuous Drain Current, V <sub>GS</sub> @ 10V		8.2	
I <sub>D</sub> @ T <sub>mb</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	44	Α
I <sub>D</sub> @ T <sub>mb</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	28	
I <sub>DM</sub>	Pulsed Drain Current ①	220	
P <sub>D</sub> @T <sub>A</sub> = 25°C	Power Dissipation ®	3.6	w
P <sub>D</sub> @ T <sub>mb</sub> = 25°C	Power Dissipation <sup>⑤</sup>	156	T vv
	Linear Derating Factor ®	0.029	W/°C
$T_J$	Operating Junction and	-55 to + 150	°C
T <sub>STG</sub>	Storage Temperature Range		

Notes ① through ⑤ are on page 9



# Static @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
BV <sub>DSS</sub>	Drain-to-Source Breakdown Voltage	150			V	$V_{GS} = 0V, I_D = 250uA$
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.12		V/°C	Reference to 25°C, I <sub>D</sub> = 1.0mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		25.5	31	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 34A ③
$V_{GS(th)}$	Gate Threshold Voltage	3.0		5.0	V	V - V I - 150uA
$\Delta V_{GS(th)}$	Gate Threshold Voltage Coefficient		-12		mV/°C	$V_{DS} = V_{GS}, I_D = 150\mu A$
I <sub>DSS</sub>	Drain-to-Source Leakage Current			20		$V_{DS} = 150V, V_{GS} = 0V$
				250	μA	$V_{DS} = 150V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			100	nA	V <sub>GS</sub> = 20V
	Gate-to-Source Reverse Leakage			-100	I IIA	V <sub>GS</sub> = -20V
gfs	Forward Transconductance	38			S	$V_{DS} = 50V, I_{D} = 34A$
$Q_g$	Total Gate Charge		36	54		
Q <sub>gs1</sub>	Pre-Vth Gate-to-Source Charge		13		1	$V_{DS} = 75V$
Q <sub>gs2</sub>	Post-Vth Gate-to-Source Charge		4.6		nC	V <sub>GS</sub> = 10V
$Q_gd$	Gate-to-Drain Charge		11		nC nC	$I_D = 34A$
$Q_{godr}$	Gate Charge Overdrive		7.4			
$Q_{sw}$	Switch Charge (Q <sub>gs2</sub> + Q <sub>gd</sub> )		15.6			
Q <sub>oss</sub>	Output Charge		14		nC	$V_{DS} = 16V, V_{GS} = 0V$
$R_G$	Gate Resistance		1.7		Ω	
t <sub>d(on)</sub>	Turn-On Delay Time		9.4			$V_{DD} = 75V, V_{GS} = 10V$
t <sub>r</sub>	Rise Time		9.7			$I_D = 34A$
$t_{d(off)}$	Turn-Off Delay Time		14		ns	$R_G=1.3\Omega$
t <sub>f</sub>	Fall Time		3.4			
C <sub>iss</sub>	Input Capacitance		2300			V <sub>GS</sub> = 0V
C <sub>oss</sub>	Output Capacitance		205		pF	$V_{DS} = 50V$
C <sub>rss</sub>	Reverse Transfer Capacitance		47		1	f = 1.0MHz

## **Avalanche Characteristics**

	Parameter	Тур.	Max.	Units
E <sub>AS</sub>	Single Pulse Avalanche Energy ②		230	mJ
I <sub>AR</sub>	Avalanche Current ①		34	Α

## **Diode Characteristics**

	Parameter	Min.	Тур.	Max.	Units	Conditions
I <sub>S</sub>	Continuous Source Current			56		MOSFET symbol
	(Body Diode)			36		showing the
I <sub>SM</sub>	Pulsed Source Current			220	Α	integral reverse
	(Body Diode) ①			220		p-n junction diode.
$V_{SD}$	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C$ , $I_S = 34A$ , $V_{GS} = 0V$ ③
t <sub>rr</sub>	Reverse Recovery Time		52	78	ns	$T_J = 25^{\circ}C$ , $I_F = 34A$ , $V_{DD} = 75V$
Q <sub>rr</sub>	Reverse Recovery Charge		550	825	nC	di/dt = 500A/μs ③
t <sub>on</sub>	Forward Turn-On Time	Time is	Time is dominated by parasitic Inductance			

## **Thermal Resistance**

	Parameter	Тур.	Max.	Units
R <sub>0JC-mb</sub>	Junction-to-Mounting Base	0.5	0.8	
R <sub>eJC</sub> (Top)	Junction-to-Case @		15	°C/W
$R_{\theta JA}$	Junction-to-Ambient ®		35	
R <sub>0JA</sub> (<10s)	Junction-to-Ambient ®		22	



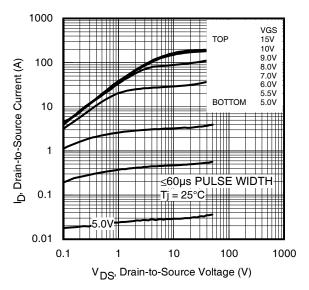


Fig 1. Typical Output Characteristics

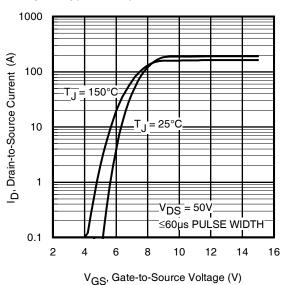


Fig 3. Typical Transfer Characteristics

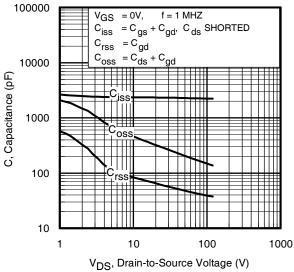


Fig 5. Typical Capacitance vs.Drain-to-Source Voltage

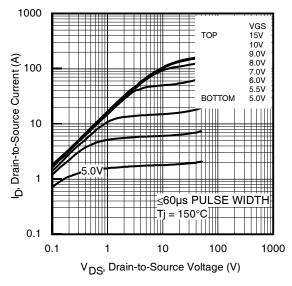


Fig 2. Typical Output Characteristics

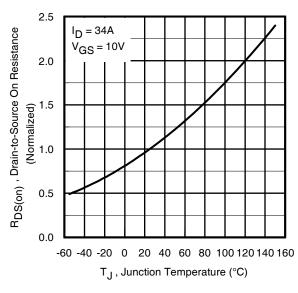


Fig 4. Normalized On-Resistance vs. Temperature

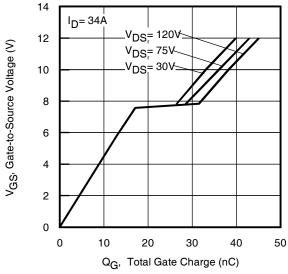


Fig 6. Typical Gate Charge vs.Gate-to-Source Voltage



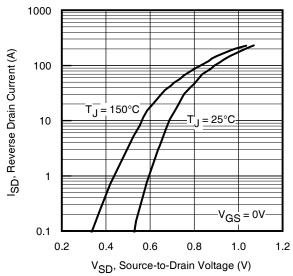
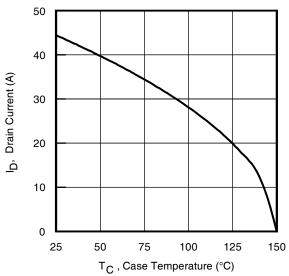


Fig 7. Typical Source-Drain Diode Forward Voltage



**Fig 9.** Maximum Drain Current vs. Case Temperature

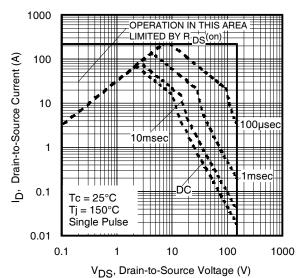


Fig 8. Maximum Safe Operating Area

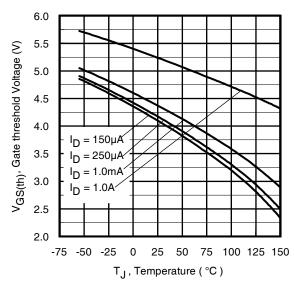


Fig 10. Threshold Voltage vs. Temperature

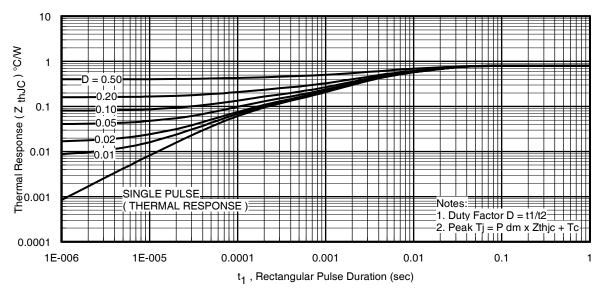
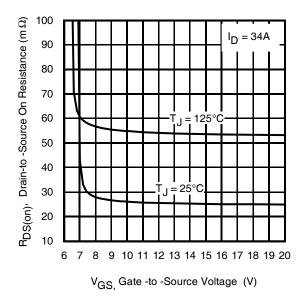


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Mounting Base





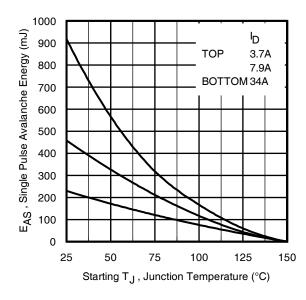


Fig 12. On-Resistance vs. Gate Voltage

Fig 13. Maximum Avalanche Energy vs. Drain Current

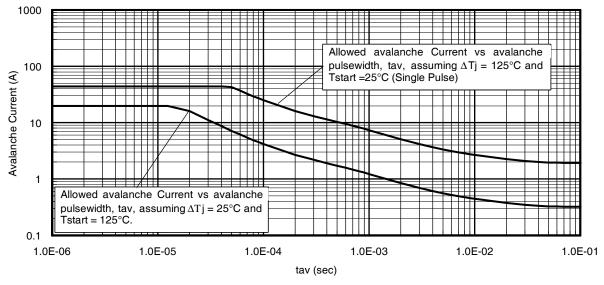


Fig 14. Typical Avalanche Current vs. Pulsewidth



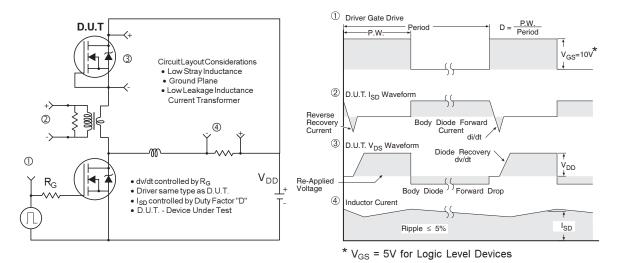


Fig 15. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

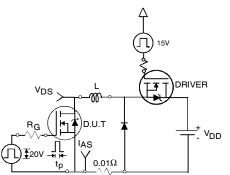


Fig 16a. Unclamped Inductive Test Circuit

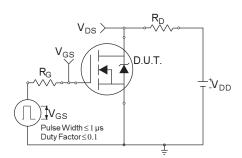


Fig 17a. Switching Time Test Circuit

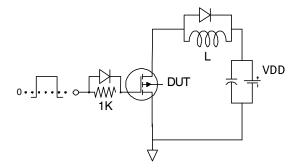


Fig 18a. Gate Charge Test Circuit

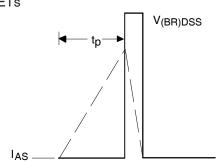


Fig 16b. Unclamped Inductive Waveforms

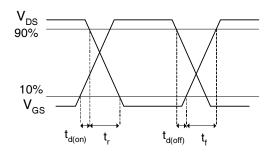


Fig 17b. Switching Time Waveforms

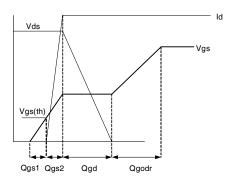
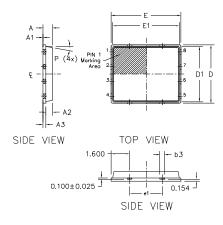
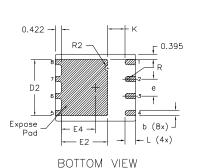


Fig 18b. Gate Charge Waveform



# PQFN 5x6 Outline "B" Package Details



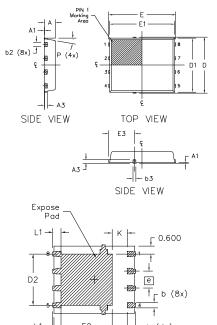


DIM	MILLIM	IITERS	IN	ICH	
SYMBOL	MIN	MAX	MIN	MAX	
А	0.800	0.900	0.0315	0.0543	
A1	0.000	0.050	0.0000	0.0020	
А3	0.20	0 REF	0.007	'9 REF	
b	0.350	0.470	0.0138	0.0185	
b1	0.025	0.125	0.0010	0.0049	
b2	0.210	0.410	0.0083	0.0161	
b3	0.150	0.450	0.0059	0.0177	
D	5.00	O BSC	0.1969 BSC		
D1	4.75	0 BSC	0.1870 BSC		
D2	4.100	4.300	0.1614	0.1693	
E	6.00	0 BSC	0.2362 BSC		
E1	5.75	0 BSC	0.2264 BSC		
E2	3.380	3,780	0.1331	0.1488	
е	1.27	70 REF	0.0500 REF		
e1	2.80	00 REF	0.11	02 REF	
K	1.200	1.420	0.0472	0.0559	
L	0.710	0.900	0.0280	0.0354	
Р	0°	12°	0°	12°	
R	0.200	REF	0.0079 REF		
R2	0.150	0.200	0.0059	0.0079	

#### Note:

- Dimensions and taleranceing confirm to ASME Y14,5M-1994
- Dimension L represents terminal full back from package edge up to 0.1mm is acceptable.
- Coplanarity applies to the expose Heat Slug as well as the terminal
- 4, Radius on terminal is Optional

# PQFN 5x6 Outline "G" Package Details



BOTTOM VIEW

DIM	MILLIM	IETERS	II.	NCH			
SYMBOL	MIN.	MAX.	MIN.	MAX.			
Α	0.950	1.050	0.0374	0.0413			
A1	0.000	0.050	0.0000	0.0020			
А3	0.254	REF	0.0100	REF			
b	0.310	0.510	0.0122	0.0201			
b1	0.025	0.125	0.0010	0.0049			
b2	0.210	0.410	0.0083	0.0161			
b3	0.180	0.450	0.0071	0.0177			
D	5.150 BSC		0.2028 BSC				
D1	5.000	BSC	0.1969 BSC				
D2	3.700	3.900	0.1457	0.1535			
E	6.150	6.150 BSC 0.2421 BSC		BSC			
E1	6.000	BSC	0.2362 BSC				
E2	3.560	3.760	0.1402	0.1488			
E3	2.270	2.470	0.0894	0.0972			
е	1.27	REF	0.050	REF			
K	0.830	1.400	0.0327	0.0551			
L	0.510	0.710	0.0201	0.0280			
L1	0.510	0.710	0.0201	0.0280			
Р	10 deg	12 deg	0 deg	12 deg			

#### Note:

- Dimensions and toleranceing confirm to ASME Y14,5M-1994
- Dimension L represents terminal full back from package edge up to 0.1mm is acceptable
- Coplanarity applies to the expose Heat Slug as well as the terminal
- 4. Radius on terminal is Optional

For more information on board mounting, including footprint and stencil recommendation, please refer to application note AN-1136: <a href="http://www.irf.com/technical-info/appnotes/an-1136.pdf">http://www.irf.com/technical-info/appnotes/an-1136.pdf</a>

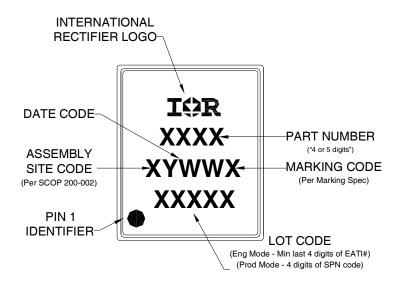
For more information on package inspection techniques, please refer to application note AN-1154:

http://www.irf.com/technical-info/appnotes/an-1154.pdf

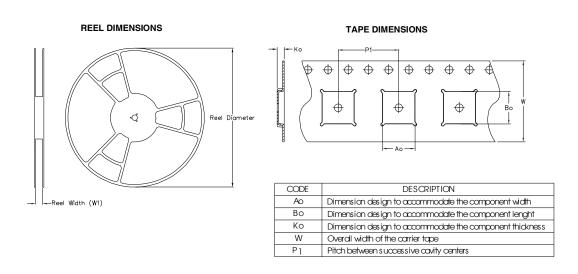
Note: For the most current drawing please refer to IR website at: http://www.irf.com/package/



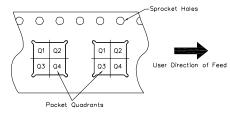
# **PQFN 5x6 Part Marking**



# **PQFN 5x6 Tape and Reel**



### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



Submit Datasheet Feedback

### Note: All dimension are nominal

Package Type	Reel Diameter (Inch)	QTY	Reel Width W1 (mm)	Ao (mm)	Bo (mm)	Ko (mm)	P1 (mm)	W (mm)	Pin 1 Quadrant
5 X 6 PQFN	13	4000	12.4	6.300	5.300	1.20	8.00	12	Q1

Note: For the most current drawing please refer to IR website at: http://www.irf.com/package/



### Qualification information<sup>†</sup>

Qualification level	Industrial <sup>††</sup> (per JEDEC JESD47F <sup>†††</sup> guidelines )	
Moisture Sensitivity Level	PQFN 5mm x 6mm	MSL1 (per JE DE C J-ST D-020D <sup>†††</sup> )
RoHS compliant	Yes	

- † Qualification standards can be found at International Rectifier's web site http://www.irf.com/product-info/reliability
- †† Higher qualification ratings may be available should the user have such requirements. Please contact your International Rectifier sales representative for further information: http://www.irf.com/whoto-call/salesrep/
- ††† Applicable version of JEDEC standard at the time of product release.

#### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Starting  $T_J = 25$ °C, L = 0.41mH,  $R_G = 25\Omega$ ,  $I_{AS} = 34$ A.
- 4 R<sub> $\theta$ </sub> is measured at T<sub>J</sub> of approximately 90°C.
- ⑤ When mounted on 1 inch square 2 oz copper pad on 1.5x1.5 in. board of FR-4 material.

**Revision History** 

no vielon iniciony	
Date	Comment
4/28/2015	Updated package outline for "option B" and added package outline for "option G" on page 7
	Updated tape and reel on page 8.
5/19/2015	Updated package outline for "option G" on page 7.
	Updated "IFX logo" on page 1 and page 9.



AN INFINEON TECHNOLOGIES COMPANY

IR WORLD HEADQUARTERS: 101 N. Sepulveda Blvd., El Segundo, California 90245, USA To contact International Rectifier, please visit <a href="http://www.irf.com/whoto-call/">http://www.irf.com/whoto-call/</a>

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